## Supporting Information

## Self-Limiting Opto-Electrochemical Thinning of Transition Metal Dichalcogenides

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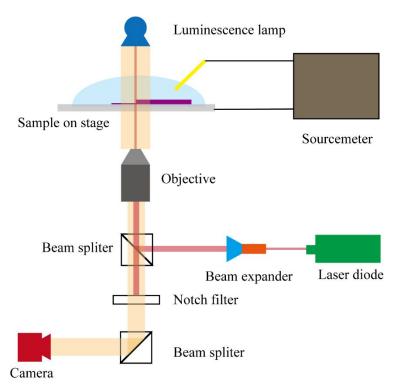
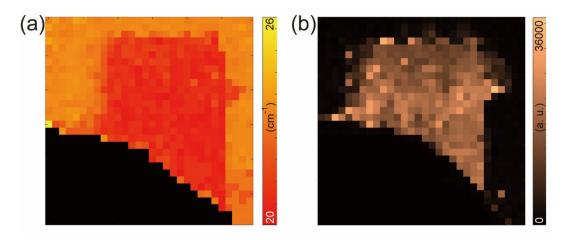


Figure S1. Schematic showing the experimental setup of sOET.



**Figure S2.** Raman scattering and PL mapping of the thinned  $MoS_2$  in Figure 1. (a) Spatial mapping of the Raman frequency distance between  $E^{1}_{2g}$  mode and  $A_{1g}$  mode of  $MoS_2$ . (b) Spatial mapping of the integrated PL intensity from 600 nm to 750 nm. Both the reduced Raman frequency distance of ~ 20.5 cm<sup>-1</sup> and enhanced PL intensity indicate the monolayer feature in the laser scanned area.

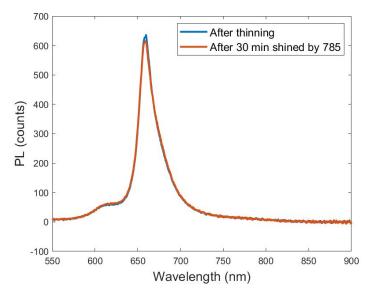
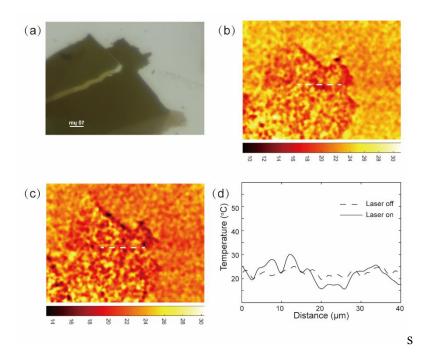
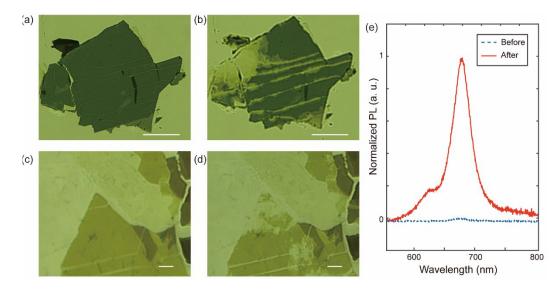


Figure S3. PL spectra of the thinned  $MoS_2$  before and after laser excitation of 30 min. No obvious difference in the PL intensity was observed.



**Figure S4.** Temperature increase induced by a 0.102 mW  $\mu$ m<sup>2</sup> 785 nm lasers irradiation on a MoS<sub>2</sub> flake in DI water. (a) Optical image of the MoS<sub>2</sub> flake; (b) Background temperature distribution when the laser was off, the ambient temperature was ~22 °C; (c) Temperature distribution when a 785 nm laser was directed on the MoS<sub>2</sub> flake.(d) Cross-sections of the temperature distribution with the laser off/on made at the white dashed line in (b) and (c). Scale bar: 10 µm.



**Figure S5.** Thinning of  $MoS_2$  on thin gold film and graphene with no bias. a-b) Optical images of a  $MoS_2$  flake on 5 nm gold film before (a) and after (b) illuminated by a 0.256 mW  $\mu$ m<sup>-2</sup> 785 nm laser for 30 s in DI water. c-d) Optical images of a  $MoS_2$  flake on monolayer graphene (glass substrate) before (c) and after (d) illuminated by a 0.257 mW  $\mu$ m<sup>-2</sup> 785 nm laser for 30 s DI water. Even without applying bias, the thickness of the multilayer  $MoS_2$  was reduced. (e) PL spectra before (blue dashed) and after thinning. Scale bars are 25  $\mu$ m.

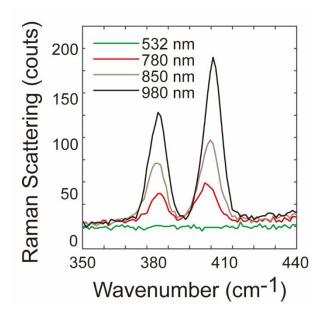
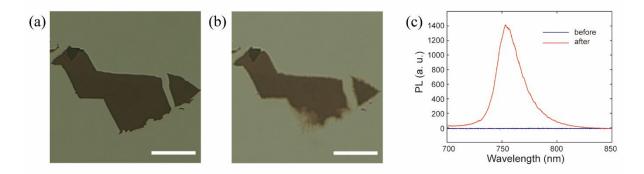


Figure S6. Raman spectra of MoS<sub>2</sub> flakes after scanning by different lasers.



**Figure S7.** sOET of WSe<sub>2</sub>. (a) Optical image of the WSe<sub>2</sub> flake before thinning. (b) Optical image of the WSe<sub>2</sub> flake after thinning. (c) PL spectra before and after thinning. Scale bars are  $10 \mu m$ .